

EXPRESS MAIL No.: EL 645 879 550 US

Deposited: March 7, 2002

I hereby certify that this correspondence is being deposited with the United States Postal Service Express mail under 37 CFR 1.10 on the date indicated above and is addressed to: Box PCT, Commissioner for Patents, Washington, DC 20231



/ Ruth Montalvo Date: 03/07/02

1743
#3
✓
03/25/02

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Customer No. 026418

Attorney's Docket No.: JG-YY-5116/500569.20081

Applicant(s) Masaaki TERASHIMA, et al.

U.S. Application No.: 10/006,169

Group No.:

Filed: December 6, 2001

Examiner:

For: DEVICE FOR MEASURING IONIC ACTIVITIES

Commissioner of Patents
Washington, D. C. 20231

INFORMATION DISCLOSURE STATEMENT

S I R:

Applicant hereby submits the following references::

	Document Number	Date	Name and/or Country
AA	4,571,293	2/18/1986	US
AB	4,789,435	12/6/1988	US
AC	4,053,381	10/11/1977	US
AD	4,171,246	10/16/1979	US
AE	4,219,968	9/2/1980	US

RECEIVED
MAR 19 2002
TC 1700

Accompanying this Information Disclosure Statement and form PTO-1449 are copies of the aforementioned documents.

This submission is not an admission that the information disclosed in the documents is material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,

Jules E. Goldberg - Reg. No. 24,408
Reed Smith LLP
375 Park Avenue
New York, NY 10152

JEG:dej
03/07/02
Tel. (212) 521-5403
Enclosures:
PTO-1449; 5 documents

LIST OF PRIOR ART CITED BY APPLICANT
(Filed on March 7, 2002)

Docket No. JG-YY-5116/500569.20081
Applicant(s): Masaaki TERASHIMA, et al.
Application No. 10/006,169
Filed: December 6, 2001



Group: --
Examiner: --

U.S. PATENT DOCUMENTS

Exam. Init		Document Number	Date	Name	Class	Sub-Class	Filing Date Appropriate
	AA	4,571,293	2/18/1986	Seshimoto et al	204	408	
	AB	4,789,435	12/6/1988	Seshimoto et al	204	1 T	
	AC	4,053,381	10/11/1977	Hambien, et al.	204	195	
	AD	4,171,246	10/16/1979	Hambien, et al.	204	1 T	
	AE	4,219,968	9/2/1980	Sakai, et al.	49	40	
	AF						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	CLASS	Sub-Class	Translation YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							
	AQ							
	AR							

RECEIVED
MAR 19 2002
TC 1700

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	AT	
	AU	
	AV	
	AV	
Examiner:		Date:

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.